Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	tent under
10/696,139	RHEE ET AL.	
Examiner	Art Unit	
 Linh M. Nguyen	2816	

	SEARCHED			
Class	Subclass	Date	Examiner	
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INT	INTERFERENCE SEARCHED				
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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